

Solid-state lighting measurement assurance program (2)

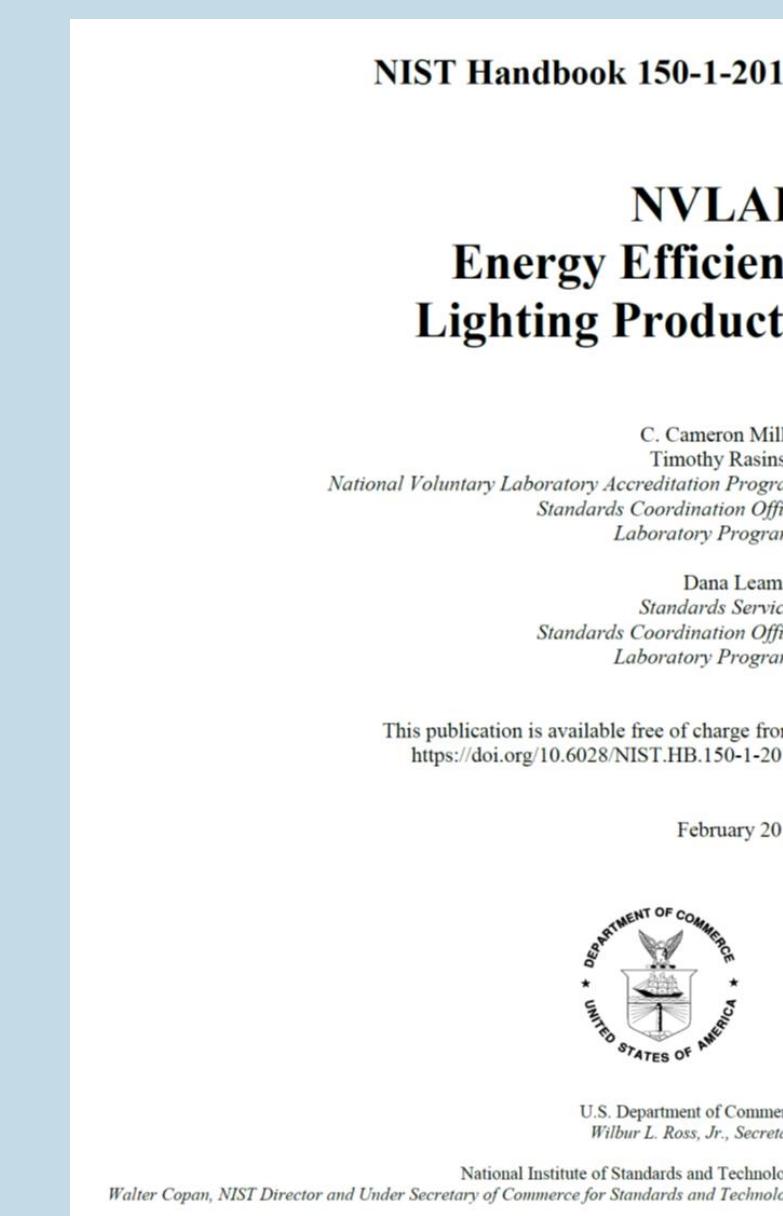
Cameron Miller, Benjamin Tsai, Yuqin Zong & Maria Nadal

National Institute of Standards & Technology

SSL Standards & Accreditation History



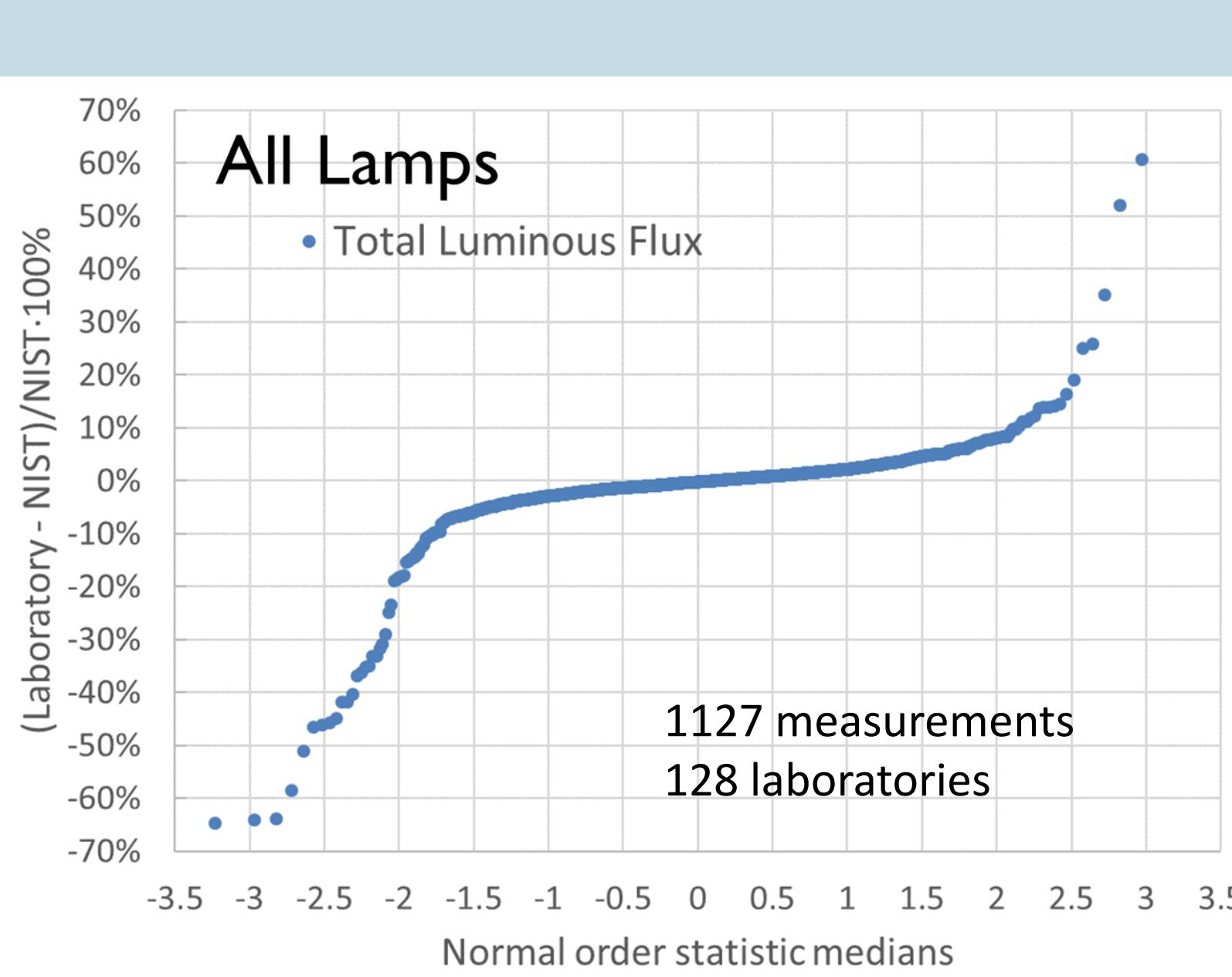
- IES Publishes LM-79-2008 -> LM-79-2019
- 2009 NVLAP Laboratory Accreditation Program
- Measurement assurance program (MAP 1)
 - Jan 2010 – Dec 2014
- Measurement assurance program (MAP 2)
 - Jan 2015 – Dec 2020



MAP Artifacts & Quantities

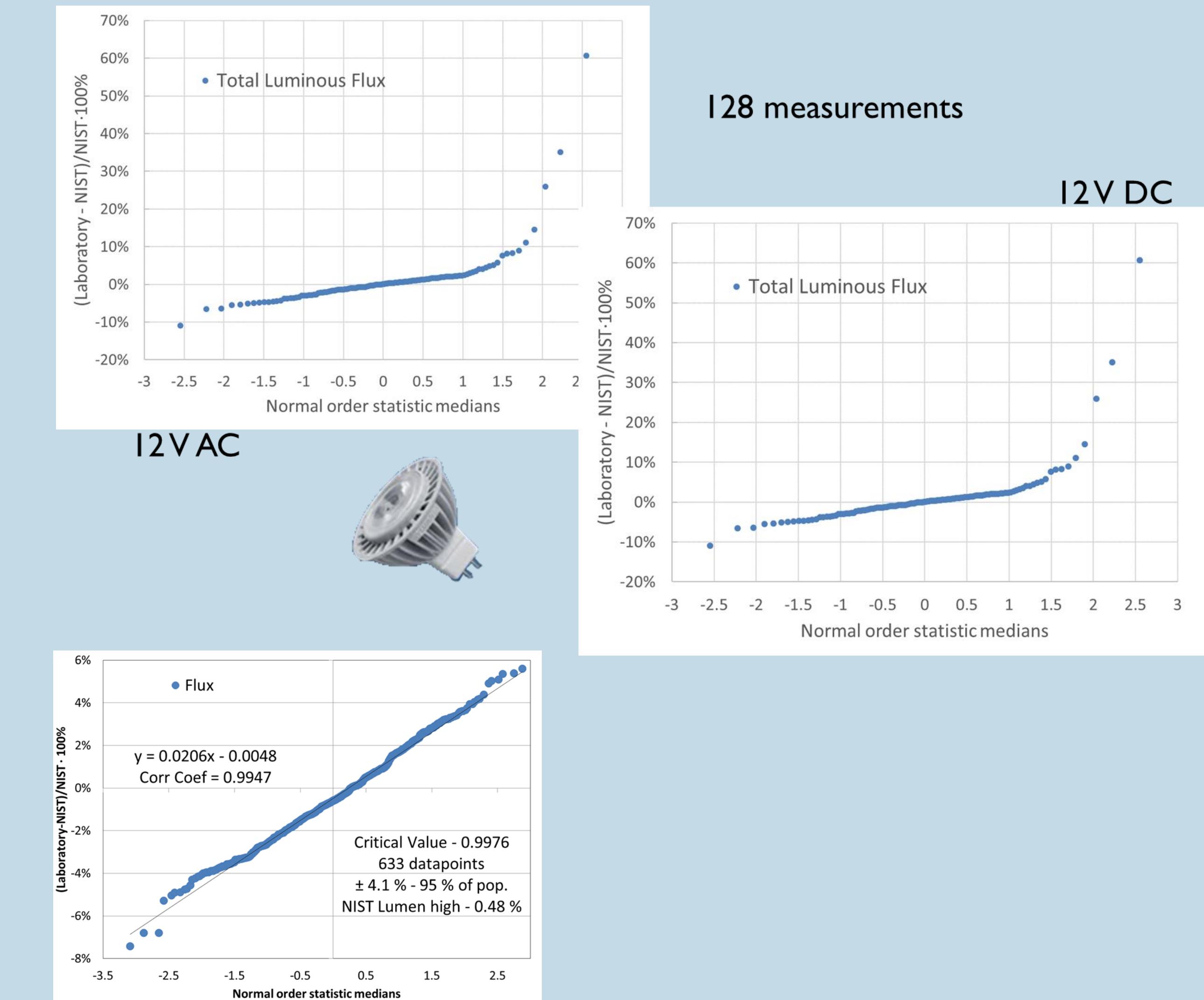
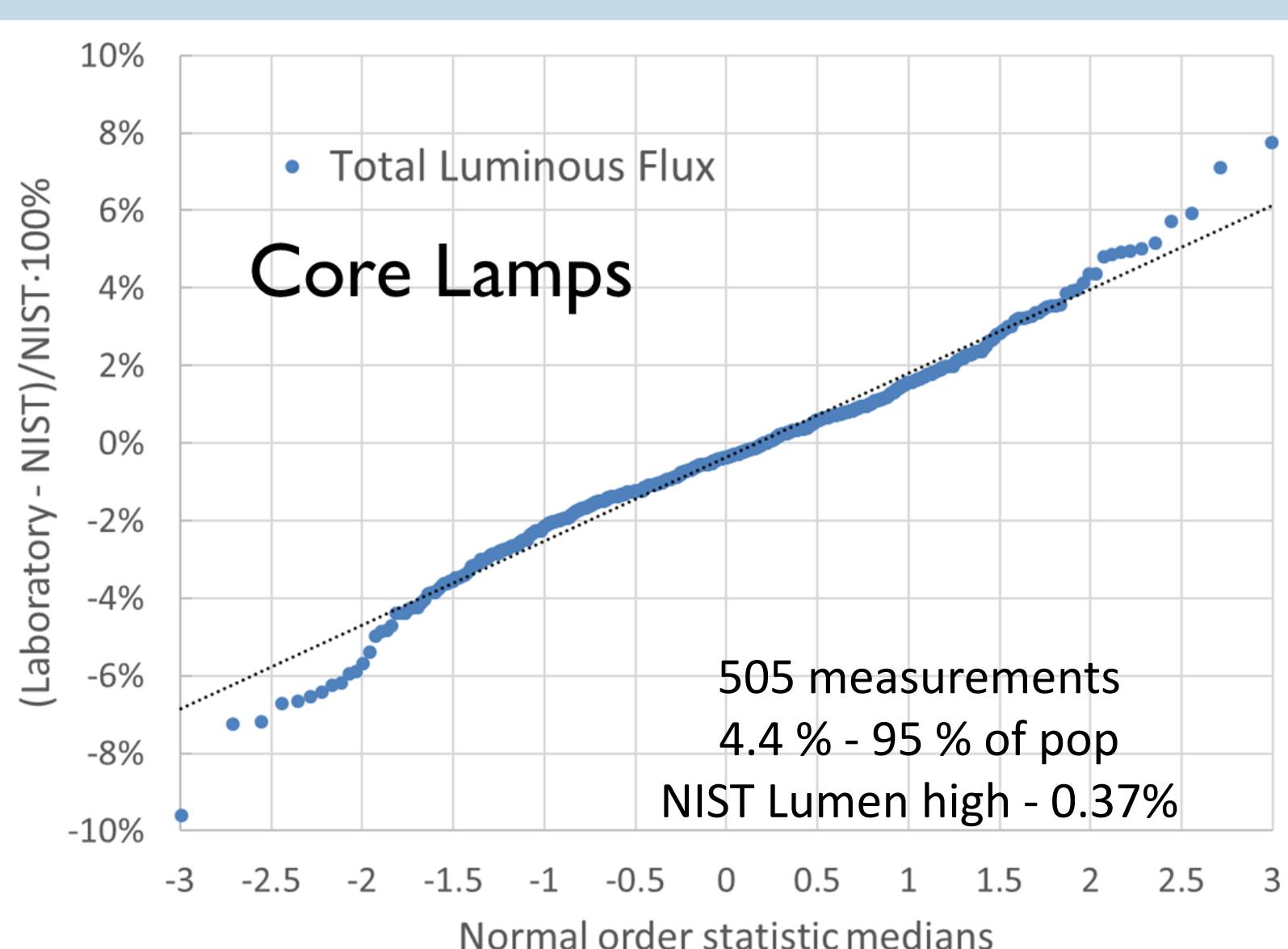


128 laboratories



Measured Properties of Lamps

RMS Voltage and Current Chromaticity Coordinates (x,y)	Luminous Flux	Color Rendering Index	Correlated Color Temperature
	Total Luminous Flux		
		Power Efficacy	



Measurement Assurance Program Results

118 laboratories participated

United States (49) China (45) Taiwan (9)
Korea (4) Canada (3) Netherlands
Brazil Singapore India
Malaysia Hungary Italy Germany

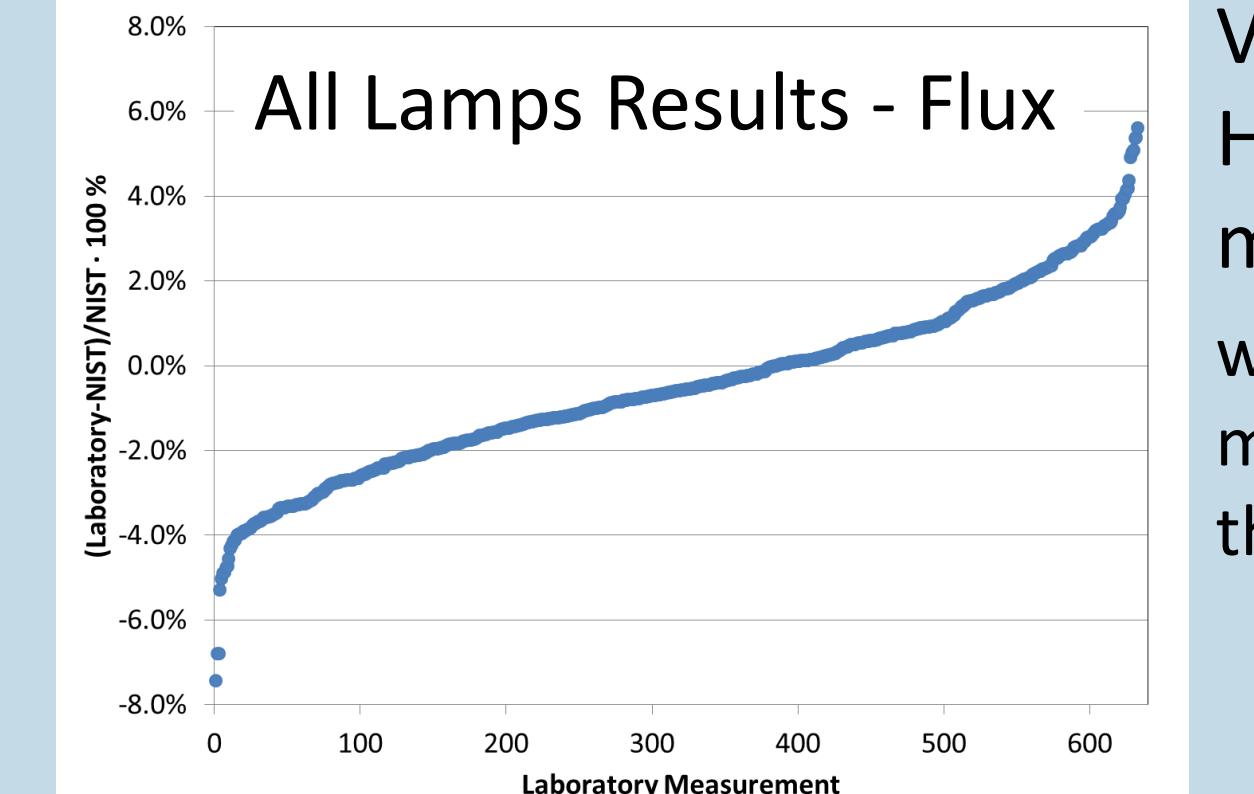
LEUKOS

The journal of the Illuminating Engineering Society of North America

- MAP 1 results paper published 2016:
C.C. Miller, H. Hastings, and M.E. Nadal (2016): A Snapshot of 118 Solid State Lighting Testing Laboratories' Capabilities, LEUKOS, DOI:10.1080/15502724.2016.1189834.

Normal Probability Plot

Vertical axis: Ordered response values
Horizontal axis: Normal order statistic medians $N_i = G(U_i)$
where U_i are the uniform order statistic medians; G is the percent point function of the normal distribution
 $U_1 = 1 - U_n$ for $i = 1$
 $U_i = (i - 0.3175)/(n + 0.365)$ for $i = 2, 3, \dots, n-1$
 $U_n = 0.5(1/n)$ for $i = n$



<http://www.itl.nist.gov/div898/handbook/eda/section3/normprpl.htm>

Graphical technique for if data is approximately normally distributed. (Chambers, 1983)

